Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,408	MAK, JOHN	
Examiner	Art Unit	
lves Wu	1797	

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95	263,266,2 35	11/29/2007	ΙWU
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
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text search - EAST	11/29/2007	IWU